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MULTILAYER CERAMIC CAPACITORS



WAVE

REFLOW

PARTS NUMBER

J	M	K	3	1	6	△	B	J	1	0	6	M	L	—	T	△
①	②	③	④	⑤	⑥	⑦	⑧	⑨	⑩	⑪	⑫					

△=Blank space

①Rated voltage

Code	Rated voltage[VDC]
P	2.5
A	4
J	6.3
L	10
E	16
T	25
G	35
U	50
H	100
Q	250
S	630

②Series name

Code	Series name
M	Multilayer ceramic capacitor
V	Multilayer ceramic capacitor for high frequency
W	LW reverse type multilayer capacitor

③End termination

Code	End termination
K	Plated
S	Cu Internal Electrodes

④Dimension (L × W)

Type	Dimensions (L × W) [mm]	EIA (inch)
042	0.4 × 0.2	01005
063	0.6 × 0.3	0201
105	1.0 × 0.5	0402
	0.52 × 1.0 ※	0204
107	1.6 × 0.8	0603
	0.8 × 1.6 ※	0306
212	2.0 × 1.25	0805
	1.25 × 2.0 ※	0508
316	3.2 × 1.6	1206
325	3.2 × 2.5	1210
432	4.5 × 3.2	1812

Note : ※LW reverse type(□WK) only

⑤Dimension tolerance

Code	Type	L[mm]	W[mm]	T[mm]
△	ALL	Standard	Standard	Standard
A	063	0.6±0.05	0.3±0.05	0.3±0.05
	105	1.0±0.10	0.5±0.10	0.5±0.10
	107	1.6+0.15/−0.05	0.8+0.15/−0.05	0.8+0.15/−0.05
	212	2.0+0.15/−0.05	1.25+0.15/−0.05	0.45±0.05 0.85±0.10 1.25+0.15/−0.05
	316	3.2±0.20	1.6±0.20	0.85±0.10 1.6±0.20
	325	3.2±0.30	2.5±0.30	2.5±0.30
B	105	1.0+0.15/−0.05	0.5+0.15/−0.05	0.5+0.15/−0.05
	107	1.6+0.20/−0	0.8+0.20/−0	0.45±0.05 0.8+0.20/−0
	212	2.0+0.20/−0	1.25+0.20/−0	0.85±0.10 1.25+0.20/−0
	316	3.2±0.30	1.6±0.30	1.6±0.30
C	105	1.0+0.20/−0	0.5+0.20/−0	0.5+0.20/−0

Note: P.6 Standard external dimensions

△= Blank space

⑥Temperature characteristics code

■High dielectric type (Excluding Super low distortion multilayer ceramic capacitor(CFCAP™))

Code	Applicable standard	Temperature range[°C]	Ref. Temp.[°C]	Capacitance change	Capacitance tolerance	Tolerance code
BJ	JIS	B	−25~+85	20	±10%	K
					±20%	M
	EIA	X5R	−55~+85	25	±15%	K
B7					±20%	M
	EIA	X7R	−55~+125	25	±15%	K
C6					±20%	M
	EIA	X6S	−55~+105	25	±22%	K
C7					±10%	K
	EIA	X7S	−55~+125	25	±22%	M
LD(※)					±10%	K
	EIA	X5R	−55~+85	25	±15%	M
△F	JIS	F	−25~+85	20	+30/−80%	Z
	EIA	Y5V	−30~+85	25	+22/−82%	Z

Note : ※LD Low distortion high value multilayer ceramic capacitor

△= Blank space

► This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification. For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (<http://www.ty-top.com/>).

■ Temperature compensating type

■ Temperature compensating type							
Code	Applicable standard		Temperature range [°C]	Ref. Temp. [°C]	Capacitance change	Capacitance tolerance	Tolerance code
CG	EIA	C0G	-55 ~ +125	25	0 ± 60ppm/°C	± 0.1pF	B
						± 0.25pF	C
						± 0.5pF	D
						± 1pF	F
						± 5%	J
CH	JIS	CH	-55 ~ +125	20	0 ± 60ppm/°C	± 0.1pF	B
						± 0.25pF	C
						± 0.5pF	D
	EIA	C0H		25		± 1pF	F
						± 5%	J
						± 10%	K
CJ	JIS	CJ	-55 ~ +125	20	0 ± 120ppm/°C	± 0.25pF	C
	EIA	C0J		25			
CK	JIS	CK	-55 ~ +125	20	0 ± 250ppm/°C	± 0.25pF	C
	EIA	C0J		25			
UJ	JIS	UJ	-55 ~ +125	20	-750 ± 120ppm/°C	± 0.25pF	C
	EIA	U2J		25		± 0.5pF	D
						± 5%	J
UK	JIS	UK	-55 ~ +125	20	-750 ± 250ppm/°C	± 0.5pF	C
	EIA	U2K	-55 ~ +125	25			
SL	JIS	SL	-55 ~ +125	20	+350 ~ -1000ppm/°C	± 5%	J

⑥ Series code

(Super low distortion multilayer ceramic capacitor (CFCAP™) only)

Code	Series code
SD	Standard

⑦ Nominal capacitance

Code (example)	Nominal capacitance
0R5	0.5pF
010	1pF
100	10pF
101	100pF
102	1,000pF
103	10,000pF
104	0.1 μF
105	1.0 μF
106	10 μF
107	100 μF

Note : R=Decimal point

⑧ Capacitance tolerance

Code	Capacitance tolerance
B	± 0.1pF
C	± 0.25pF
D	± 0.5pF
F	± 1pF
G	± 2%
J	± 5%
K	± 10%
M	± 20%
Z	+80/-20%

⑨ Thickness

Code	Thickness [mm]
C	0.2
D	
P	
T	0.3
K	
V	0.5
W	
A	0.8
D	0.85(212type or more)
F	1.15
G	1.25
L	1.6
N	1.9
Y	2.0 max
M	2.5

⑩ Special code

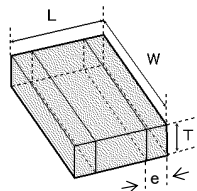
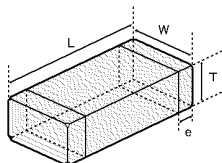
Code	Special code
—	Standard

⑪ Packaging

Code	Packaging
F	φ 178mm Taping (2mm pitch)
T	φ 178mm Taping (4mm pitch)
P	φ 178mm Taping (4mm pitch, 1000 pcs/reel) 325 type (Thickness code M)
W	φ 178mm Taping (1mm pitch) 042type only

⑫ Internal code

Code	Internal code
△	Standard



※ LW reverse type

Type(EIA)	Dimension [mm]				
	L	W	T	*1	e
□MK042(01005)	0.4±0.02	0.2±0.02	0.2±0.02	C	0.1±0.03
□VS042(01005)	0.4±0.02	0.2±0.02	0.2±0.02	D	
□MK063(0201)	0.6±0.03	0.3±0.03	0.3±0.03	P	0.15±0.05
				T	
□MK105(0402)	1.0±0.05	0.5±0.05	0.2±0.02	C	0.25±0.10
			0.3±0.03	P	
			0.5±0.05	V	
□VK105(0402)	1.0±0.05	0.5±0.05	0.5±0.05	W	0.25±0.10
□WK105(0204)※	0.52±0.05	1.0±0.05	0.3±0.05	P	0.18±0.08
□MK107(0603)	1.6±0.10	0.8±0.10	0.45±0.05	K	0.35±0.25
			0.8±0.10	A	
□WK107(0306)※	0.8±0.10	1.6±0.10	0.5±0.05	V	0.25±0.15
□MK212(0805)	2.0±0.10	1.25±0.10	0.45±0.05	K	0.5±0.25
			0.85±0.10	D	
			1.25±0.10	G	
□WK212(0508)※	1.25±0.15	2.0±0.15	0.85±0.1	D	0.3±0.2
□MK316(1206)	3.2±0.15	1.6±0.15	0.85±0.10	D	0.5+0.35/-0.25
			1.15±0.10	F	
			1.25±0.10	G	
			1.6±0.20	L	
□MK325(1210)	3.2±0.30	2.5±0.20	0.85±0.10	D	0.6±0.3
			1.15±0.10	F	
			1.9±0.20	N	
			1.9+0.1/-0.2	Y	
			2.5±0.20	M	
□MK432(1812)	4.5±0.40	3.2±0.30	2.5±0.20	M	0.9±0.6

Note : ※. LW reverse type, *1.Thickness code

■ STANDARD QUANTITY

Type	EIA (inch)	Dimension		Standard quantity [pcs]	
		[mm]	Code	Paper tape	Embossed tape
042	01005	0.2	C	—	40000
			D		
063	0201	0.3	P	15000	—
			T		
105	0402	0.2	C	20000	—
		0.3	P	15000	—
		0.5	V	10000	—
			W		
	0204 ※	0.30	P	—	—
107	0603	0.45	K	4000	—
		0.8	A		
	0306 ※	0.50	V	—	4000
212	0805	0.45	K	4000	—
		0.85	D		
		1.25	G		3000
	0508 ※	0.85	D	4000	—
316	1206	0.85	D	4000	—
		1.15	F	—	3000
		1.25	G		
		1.6	L	—	2000
325	1210	0.85	D	—	2000
		1.15	F		
		1.9	N		
		2.0 max	Y		
		2.5	M		
432	1812	2.5	M	—	500(T), 1000(P)
				—	500

Note : ※.LW Reverse type (□WK)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics		Capacitance [F]	Capacitance tolerance [%]	Q (at 1MHz) min	HTLT	Thickness*3 [mm]	Soldering R:Reflow W:Wave
								Rated voltage x %		
UMK105 CH101JV-F		50	CH	C0H	100 p	±5%	1000	200	0.5±0.05	R
UMK105 CH121JV-F			CH	C0H	120 p	±5%	1000	200	0.5±0.05	R
UMK105 CH151JV-F			CH	C0H	150 p	±5%	1000	200	0.5±0.05	R
UMK105 CH181JV-F			CH	C0H	180 p	±5%	1000	200	0.5±0.05	R
UMK105 CH221JV-F			CH	C0H	220 p	±5%	1000	200	0.5±0.05	R
UMK105 CH271JV-F			CH	C0H	270 p	±5%	1000	200	0.5±0.05	R
UMK105 CH331JV-F			CH	C0H	330 p	±5%	1000	200	0.5±0.05	R
UMK105 CH361JV-F			CH	C0H	360 p	±5%	1000	200	0.5±0.05	R
UMK105 CH391JV-F			CH	C0H	390 p	±5%	1000	200	0.5±0.05	R
UMK105 CH431JV-F			CH	C0H	430 p	±5%	1000	200	0.5±0.05	R
UMK105 CH471JV-F			CH	C0H	470 p	±5%	1000	200	0.5±0.05	R
UMK105 CH511JV-F			CH	C0H	510 p	±5%	1000	200	0.5±0.05	R
UMK105 CH561JV-F			CH	C0H	560 p	±5%	1000	200	0.5±0.05	R
UMK105 CH621JV-F			CH	C0H	620 p	±5%	1000	200	0.5±0.05	R
UMK105 CH681JV-F			CH	C0H	680 p	±5%	1000	200	0.5±0.05	R
UMK105 CH751JV-F			CH	C0H	750 p	±5%	1000	200	0.5±0.05	R
UMK105 CH821JV-F			CH	C0H	820 p	±5%	1000	200	0.5±0.05	R
UMK105 CH102JV-F			CH	C0H	1000 p	±5%	1000	200	0.5±0.05	R

【Temperature Characteristic UΔ : UΔ/U2Δ】 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics		Capacitance [F]	Capacitance tolerance [%]	Q (at 1MHz) min	HTLT	Thickness*3 [mm]	Soldering R:Reflow W:Wave
								Rated voltage x %		
UMK105 UK0R5CV-F		50	UK	U2K	0.5 p	±0.25pF	410	200	0.5±0.05	R
UMK105 UK010CV-F			UK	U2K	1 p	±0.25pF	420	200	0.5±0.05	R
UMK105 UK1R5CV-F			UK	U2K	1.5 p	±0.25pF	430	200	0.5±0.05	R
UMK105 UK020CV-F			UK	U2K	2 p	±0.25pF	440	200	0.5±0.05	R
UMK105 UK030CV-F			UK	U2K	3 p	±0.25pF	460	200	0.5±0.05	R
UMK105 UJ040CV-F			UJ	U2J	4 p	±0.25pF	480	200	0.5±0.05	R
UMK105 UJ050CV-F			UJ	U2J	5 p	±0.25pF	500	200	0.5±0.05	R
UMK105 UJ060DV-F			UJ	U2J	6 p	±0.5pF	520	200	0.5±0.05	R
UMK105 UJ070DV-F			UJ	U2J	7 p	±0.5pF	540	200	0.5±0.05	R
UMK105 UJ080DV-F			UJ	U2J	8 p	±0.5pF	560	200	0.5±0.05	R
UMK105 UJ090DV-F			UJ	U2J	9 p	±0.5pF	580	200	0.5±0.05	R
UMK105 UJ100DV-F			UJ	U2J	10 p	±0.5pF	600	200	0.5±0.05	R
UMK105 UJ120JV-F			UJ	U2J	12 p	±5%	640	200	0.5±0.05	R
UMK105 UJ150JV-F			UJ	U2J	15 p	±5%	700	200	0.5±0.05	R
UMK105 UJ180JV-F			UJ	U2J	18 p	±5%	760	200	0.5±0.05	R
UMK105 UJ220JV-F			UJ	U2J	22 p	±5%	840	200	0.5±0.05	R
UMK105 UJ270JV-F			UJ	U2J	27 p	±5%	940	200	0.5±0.05	R
UMK105 UJ330JV-F			UJ	U2J	33 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ390JV-F			UJ	U2J	39 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ470JV-F			UJ	U2J	47 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ560JV-F			UJ	U2J	56 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ680JV-F			UJ	U2J	68 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ820JV-F			UJ	U2J	82 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ101JV-F			UJ	U2J	100 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ121JV-F			UJ	U2J	120 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ151JV-F			UJ	U2J	150 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ181JV-F			UJ	U2J	180 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ221JV-F			UJ	U2J	220 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ271JV-F			UJ	U2J	270 p	±5%	1000	200	0.5±0.05	R
UMK105 UJ331JV-F			UJ	U2J	330 p	±5%	1000	200	0.5±0.05	R

【Temperature Characteristic SL】 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics		Capacitance [F]	Capacitance tolerance [%]	Q (at 1MHz) min	HTLT	Thickness*3 [mm]	Soldering R:Reflow W:Wave
								Rated voltage x %		
UMK105 SL121JV-F		50	SL		120 p	±5%	1000	200	0.5±0.05	R
UMK105 SL151JV-F			SL		150 p	±5%	1000	200	0.5±0.05	R
UMK105 SL181JV-F			SL		180 p	±5%	1000	200	0.5±0.05	R
UMK105 SL221JV-F			SL		220 p	±5%	1000	200	0.5±0.05	R
UMK105 SL271JV-F			SL		270 p	±5%	1000	200	0.5±0.05	R
UMK105 SL331JV-F			SL		330 p	±5%	1000	200	0.5±0.05	R

Multilayer Ceramic Capacitors for High Frequency Applications (1GHz+)

● 042TYPE

【Temperature Characteristic CH : CH/C0H】 0.2mm thickness (C)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics		Capacitance [F]	Capacitance tolerance [%]	Q (at 1GHz) (min)	HTLT	Thickness*3 [mm]	Soldering R:Reflow W:Wave
								Rated voltage x %		
TVS042 CH0R2□C-W		25	CH	C0H	0.2 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH0R3□C-W			CH	C0H	0.3 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH0R4□C-W			CH	C0H	0.4 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH0R5□C-W			CH	C0H	0.5 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH0R6□C-W			CH	C0H	0.6 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH0R7□C-W			CH	C0H	0.7 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH0R75□C-W			CH	C0H	0.75 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH0R8□C-W			CH	C0H	0.8 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH0R9□C-W			CH	C0H	0.9 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH010□C-W			CH	C0H	1 p	±0.1pF, 0.25pF	300	200	0.2±0.02	R
TVS042 CH1R1□C-W			CH	C0H	1.1 p	±0.1pF, 0.25pF	280	200	0.2±0.02	R
TVS042 CH1R2□C-W			CH	C0H	1.2 p	±0.1pF, 0.25pF	270	200	0.2±0.02	R
TVS042 CH1R3□C-W			CH	C0H	1.3 p	±0.1pF, 0.25pF	260	200	0.2±0.02	R
TVS042 CH1R5□C-W			CH	C0H	1.5 p	±0.1pF, 0.25pF	240	200	0.2±0.02	R
TVS042 CH1R6□C-W			CH	C0H	1.6 p	±0.1pF, 0.25pF	230	200	0.2±0.02	R
TVS042 CH1R8□C-W			CH	C0H	1.8 p	±0.1pF, 0.25pF	210	200	0.2±0.02	R
TVS042 CH020□C-W			CH	C0H	2 p	±0.1pF, 0.25pF	190	200	0.2±0.02	R
TVS042 CH2R2□C-W			CH	C0H	2.2 p	±0.1pF, 0.25pF	180	200	0.2±0.02	R
TVS042 CH2R4□C-W			CH	C0H	2.4 p	±0.1pF, 0.25pF	170	200	0.2±0.02	R

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Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	Q (at 1GHz) (min)	HTLT	Thickness*3 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
TVS042 CH2R7[C-W]		25	CH C0H	2.7 p	±0.1pF, 0.25pF	150	200	0.2±0.02	R
TVS042 CH030[C-W]			CH C0H	3 p	±0.1pF, 0.25pF	130	200	0.2±0.02	R
TVS042 CH3R3[C-W]			CH C0H	3.3 p	±0.1pF, 0.25pF	120	200	0.2±0.02	R
TVS042 CH3R6[C-W]			CH C0H	3.6 p	±0.1pF, 0.25pF	110	200	0.2±0.02	R
TVS042 CH3R9[C-W]			CH C0H	3.9 p	±0.1pF, 0.25pF	100	200	0.2±0.02	R
TVS042 CH040[C-W]			CH C0H	4 p	±0.1pF, 0.25pF	90	200	0.2±0.02	R
TVS042 CH4R3[C-W]			CH C0H	4.3 p	±0.1pF, 0.25pF	85	200	0.2±0.02	R
TVS042 CH4R7[C-W]			CH C0H	4.7 p	±0.1pF, 0.25pF	85	200	0.2±0.02	R
TVS042 CH050[C-W]			CH C0H	5 p	±0.1pF, 0.25pF	80	200	0.2±0.02	R
TVS042 CH5R1[C-W]			CH C0H	5.1 p	±0.25pF, 0.5pF	75	200	0.2±0.02	R
TVS042 CH5R6[C-W]			CH C0H	5.6 p	±0.25pF, 0.5pF	70	200	0.2±0.02	R
TVS042 CH060[C-W]			CH C0H	6 p	±0.25pF, 0.5pF	65	200	0.2±0.02	R
TVS042 CH6R2[C-W]			CH C0H	6.2 p	±0.25pF, 0.5pF	65	200	0.2±0.02	R
TVS042 CH6R8[C-W]			CH C0H	6.8 p	±0.25pF, 0.5pF	60	200	0.2±0.02	R
TVS042 CH070[C-W]			CH C0H	7 p	±0.25pF, 0.5pF	60	200	0.2±0.02	R
TVS042 CH7R5[C-W]			CH C0H	7.5 p	±0.25pF, 0.5pF	55	200	0.2±0.02	R
TVS042 CH080[C-W]			CH C0H	8 p	±0.25pF, 0.5pF	55	200	0.2±0.02	R
TVS042 CH8R2[C-W]			CH C0H	8.2 p	±0.25pF, 0.5pF	50	200	0.2±0.02	R
TVS042 CH090[C-W]			CH C0H	9 p	±0.25pF, 0.5pF	50	200	0.2±0.02	R
TVS042 CH9R1[C-W]			CH C0H	9.1 p	±0.25pF, 0.5pF	45	200	0.2±0.02	R
TVS042 CH100[C-W]			CH C0H	10 p	±2%, ±5%	45	200	0.2±0.02	R
TVS042 CH110JC-W			CH C0H	11 p	±5%	40	200	0.2±0.02	R
TVS042 CH120JC-W			CH C0H	12 p	±5%	40	200	0.2±0.02	R
TVS042 CH130JC-W			CH C0H	13 p	±5%	40	200	0.2±0.02	R
TVS042 CH150JC-W			CH C0H	15 p	±5%	40	200	0.2±0.02	R
TVS042 CH160JC-W			CH C0H	16 p	±5%	40	200	0.2±0.02	R
TVS042 CH180JC-W			CH C0H	18 p	±5%	40	200	0.2±0.02	R
TVS042 CH220JC-W			CH C0H	22 p	±5%	30	200	0.2±0.02	R

105TYPE

[Temperature Characteristic CH : CH/C0H] 0.5mm thickness(W)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	Q (at 1GHz) (min)	HTLT	Thickness*3 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
EVK105 CH0R3BW-F		16	CH C0H	0.3 p	±0.1pF	300	200	0.5±0.05	R
EVK105 CH0R4BW-F			CH C0H	0.4 p	±0.1pF	300	200	0.5±0.05	R
EVK105 CH0R5BW-F			CH C0H	0.5 p	±0.1pF	300	200	0.5±0.05	R
EVK105 CH0R6BW-F			CH C0H	0.6 p	±0.1pF	300	200	0.5±0.05	R
EVK105 CH0R7BW-F			CH C0H	0.7 p	±0.1pF	300	200	0.5±0.05	R
EVK105 CH0R8BW-F			CH C0H	0.8 p	±0.1pF	300	200	0.5±0.05	R
EVK105 CH0R9BW-F			CH C0H	0.9 p	±0.1pF	300	200	0.5±0.05	R
EVK105 CH010BW-F			CH C0H	1 p	±0.1pF	300	200	0.5±0.05	R
EVK105 CH1R1BW-F			CH C0H	1.1 p	±0.1pF	280	200	0.5±0.05	R
EVK105 CH1R2BW-F			CH C0H	1.2 p	±0.1pF	270	200	0.5±0.05	R
EVK105 CH1R3BW-F			CH C0H	1.3 p	±0.1pF	260	200	0.5±0.05	R
EVK105 CH1R5BW-F			CH C0H	1.5 p	±0.1pF	240	200	0.5±0.05	R
EVK105 CH1R6BW-F			CH C0H	1.6 p	±0.1pF	230	200	0.5±0.05	R
EVK105 CH1R8BW-F			CH C0H	1.8 p	±0.1pF	210	200	0.5±0.05	R
EVK105 CH020BW-F			CH C0H	2 p	±0.1pF	190	200	0.5±0.05	R
EVK105 CH2R2JW-F			CH C0H	2.2 p	±5%	180	200	0.5±0.05	R
EVK105 CH2R4JW-F			CH C0H	2.4 p	±5%	170	200	0.5±0.05	R
EVK105 CH2R7JW-F			CH C0H	2.7 p	±5%	150	200	0.5±0.05	R
EVK105 CH030JW-F			CH C0H	3 p	±5%	130	200	0.5±0.05	R
EVK105 CH3R3JW-F			CH C0H	3.3 p	±5%	120	200	0.5±0.05	R
EVK105 CH3R6JW-F			CH C0H	3.6 p	±5%	110	200	0.5±0.05	R
EVK105 CH3R9JW-F			CH C0H	3.9 p	±5%	99	200	0.5±0.05	R
EVK105 CH4R3JW-F			CH C0H	4.3 p	±5%	84	200	0.5±0.05	R
EVK105 CH4R7JW-F			CH C0H	4.7 p	±5%	84	200	0.5±0.05	R
EVK105 CH5R1JW-F			CH C0H	5.1 p	±5%	84	200	0.5±0.05	R

[Temperature Characteristic CH : CH/C0H] 0.5mm thickness(W)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	Q (at 1GHz) (min)	HTLT	Thickness*3 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UVK105 CH0R3BW-F		50	CH C0H	0.3 p	±0.1pF	300	200	0.5±0.05	R
UVK105 CH0R4BW-F			CH C0H	0.4 p	±0.1pF	300	200	0.5±0.05	R
UVK105 CH0R5BW-F			CH C0H	0.5 p	±0.1pF	300	200	0.5±0.05	R
UVK105 CH0R6BW-F			CH C0H	0.6 p	±0.1pF	300	200	0.5±0.05	R
UVK105 CH0R7BW-F			CH C0H	0.7 p	±0.1pF	300	200	0.5±0.05	R
UVK105 CH0R8BW-F			CH C0H	0.8 p	±0.1pF	300	200	0.5±0.05	R
UVK105 CH0R9BW-F			CH C0H	0.9 p	±0.1pF	300	200	0.5±0.05	R
UVK105 CH010BW-F			CH C0H	1 p	±0.1pF	300	200	0.5±0.05	R
UVK105 CH1R1BW-F			CH C0H	1.1 p	±0.1pF	280	200	0.5±0.05	R
UVK105 CH1R2BW-F			CH C0H	1.2 p	±0.1pF	270	200	0.5±0.05	R
UVK105 CH1R3BW-F			CH C0H	1.3 p	±0.1pF	260	200	0.5±0.05	R
UVK105 CH1R5BW-F			CH C0H	1.5 p	±0.1pF	240	200	0.5±0.05	R
UVK105 CH1R6BW-F			CH C0H	1.6 p	±0.1pF	230	200	0.5±0.05	R
UVK105 CH1R8BW-F			CH C0H	1.8 p	±0.1pF	210	200	0.5±0.05	R
UVK105 CH020BW-F			CH C0H	2 p	±0.1pF	190	200	0.5±0.05	R
UVK105 CH2R2JW-F			CH C0H	2.2 p	±5%	180	200	0.5±0.05	R
UVK105 CH2R4JW-F			CH C0H	2.4 p	±5%	170	200	0.5±0.05	R
UVK105 CH2R7JW-F			CH C0H	2.7 p	±5%	150	200	0.5±0.05	R
UVK105 CH030JW-F			CH C0H	3 p	±5%	130	200	0.5±0.05	R
UVK105 CH3R3JW-F			CH C0H	3.3 p	±5%	120	200	0.5±0.05	R
UVK105 CH3R6JW-F			CH C0H	3.6 p	±5%	110	200	0.5±0.05	R
UVK105 CH3R9JW-F			CH C0H	3.9 p	±5%	99	200	0.5±0.05	R
UVK105 CH4R3JW-F			CH C0H	4.3 p	±5%	84	200	0.5±0.05	R
UVK105 CH4R7JW-F			CH C0H	4.7 p	±5%	84	200	0.5±0.05	R
UVK105 CH5R1JW-F			CH C0H	5.1 p	±5%	84	200	0.5±0.05	R

Multilayer Ceramic Capacitors

PACKAGING

① Minimum Quantity

Taped package

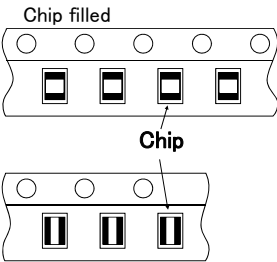
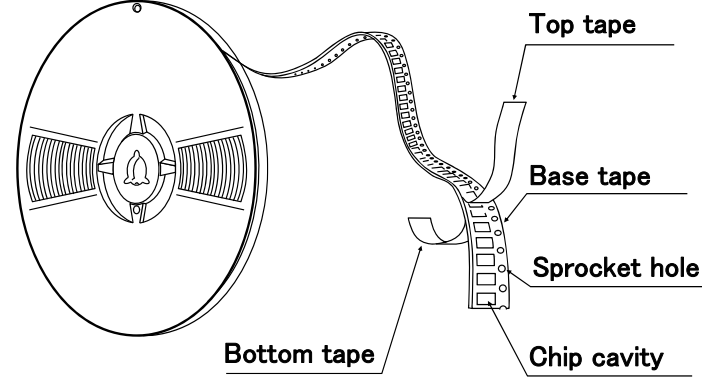
Type(EIA)	Thickness		Standard quantity [pcs]		
	mm	code	Paper tape	Embossed tape	
□MK042(01005)	0.2	C, D	—	40000	
□VS042(01005)	0.2	C			
□MK063(0201)	0.3	P, T	15000	—	
□WK105(0204) ※	0.3	P	10000		
□MK105(0402)	0.2	C	20000		
	0.3	P	15000		
	0.5	V	10000		
□VK105(0402) ※	0.5	W			
□MK107(0603)	0.45	K	4000	4000	
□WK107(0306) ※	0.5	V	—		
□MR107(0603)	0.8	A	4000		
□MK212(0805)	0.45	K		—	3000
□WK212(0508) ※	0.85	D			
□MR212(0805)	125	G			
□MK316(1206) □MR316(1206)	0.85	D	4000	—	
	1.15	F	—	3000	
	125	G			
		1.6	L	—	2000
□MK325(1210) □MR325(1210)	0.85	D	—	2000	
	1.15	F			
	1.9	N			
	2.0max.	Y			
		2.5	M	—	500(T), 1000(P)
□MK432(1812)	2.5	M			

Note : ※ LW Reverse type.

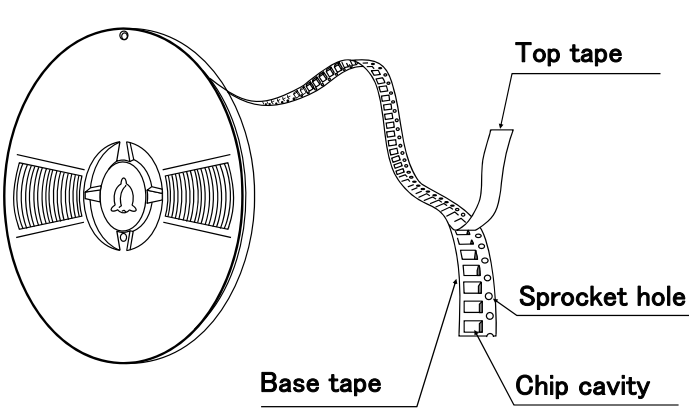
② Taping material

※No bottom tape for pressed carrier tape

Card board carrier tape



Embossed tape

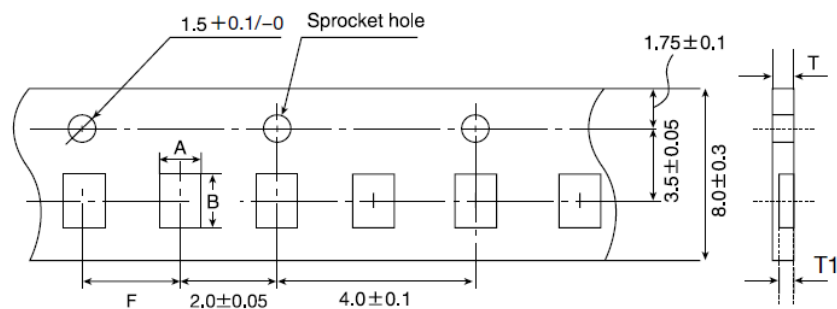


► This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification. For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (<http://www.ty-top.com/>) .

③ Representative taping dimensions

● Paper Tape (8mm wide)

● Pressed carrier tape (2mm pitch)



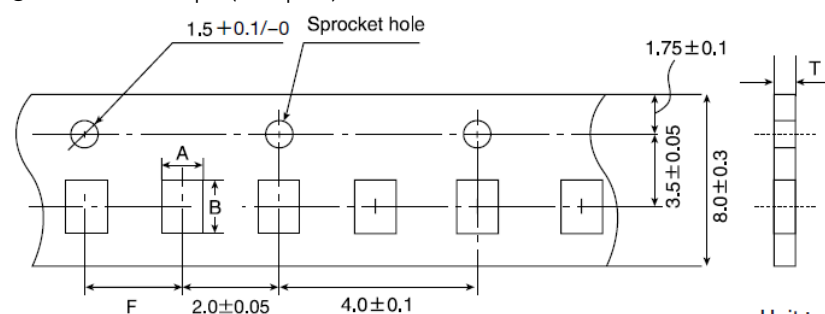
Unit : mm

Type(EIA)	Chip Cavity		Unit : mm	Insertion Pitch		Tape Thickness	
	A	B		F	T	T1	
□MK063(0201)	0.37	0.67	2.0±0.05				
□WK105(0204) ※	0.65	1.15			0.45max.	0.42max.	
□MK105(0402) (*1 C)					0.4max.	0.3max.	
□MK105(0402) (*1 P)					0.45max.	0.42max.	

Note *1 Thickness, C: 0.2mm ,P: 0.3mm. ※ LW Reverse type.

Unit : mm

● Punched carrier tape (2mm pitch)

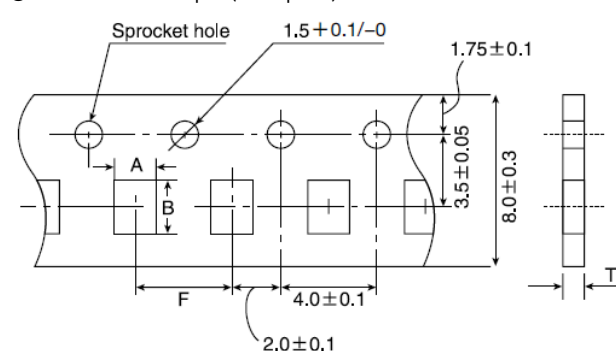


Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness
	A	B	F	T
□MK105 (0402)	0.65	1.15	2.0±0.05	0.8max.
□VK105 (0402)				

Unit : mm

● Punched carrier tape (4mm pitch)



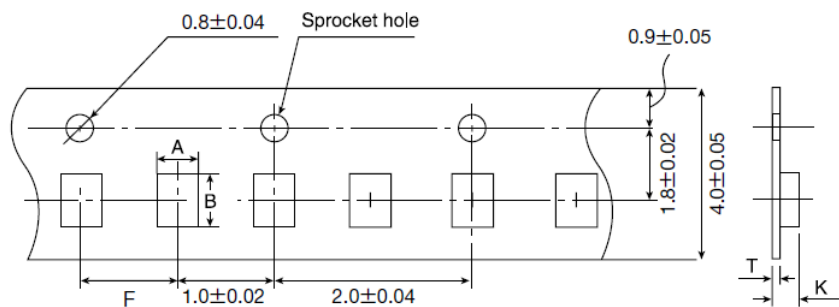
Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness		
	A	B	F	T		
□MK107(0603) □WK107(0306) ※ □MR107(0603)	1.0	1.8	4.0±0.1	1.1max.		
□MK212(0805) □WK212(0508) ※				1.65	2.4	1.1max.
□MK316(1206)						

Note : Taping size might be different depending on the size of the product. ※ LW Reverse type.

Unit : mm

● Embossed tape (4mm wide)

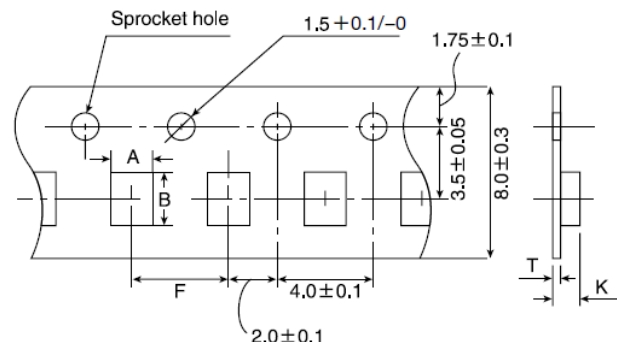


Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B	F	K	T
□MK042(01005)	0.23	0.43	1.0±0.02	0.5max.	0.25max.
□VS042(01005)					

Unit : mm

● Embossed tape (8mm wide)



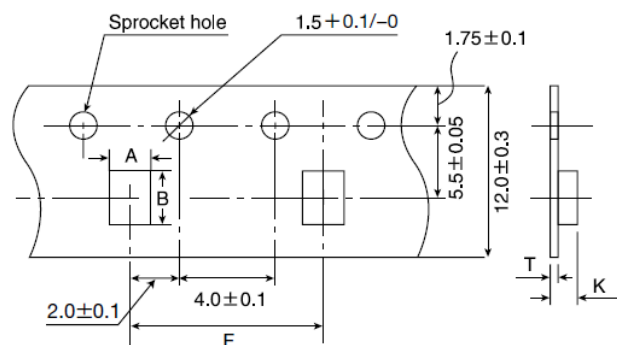
Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B	F	K	T
☐ WK107(0306) ※	1.0	1.8	4.0±0.1	1.3max.	0.25±0.1
☐ MK212(0805)	1.65	2.4		3.4max.	0.6max.
☐ MR212(0805)					
☐ MK316(1206)	2.0	3.6			
☐ MR316(1206)					
☐ MK325(1210)	2.8	3.6			
☐ MR325(1210)					

Note: ※ LW Reverse type.

Unit : mm

● Embossed tape (12mm wide)

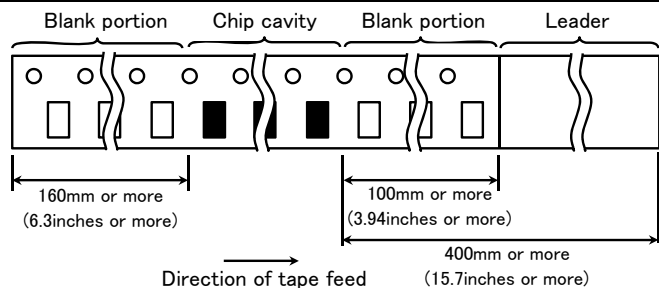


Unit : mm

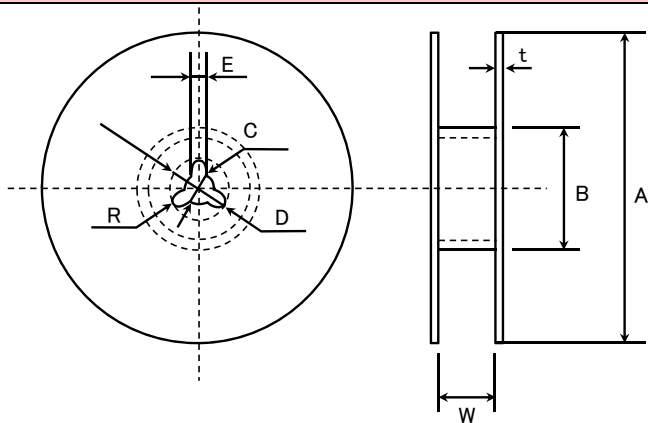
Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B	F	K	T
□MK432(1812)	3.7	4.9	8.0±0.1	4.0max.	0.6max.

Unit : mm

④Trailer and Leader



⑤Reel size



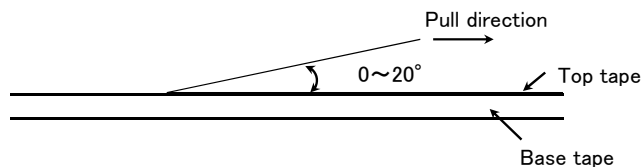
A	B	C	D	E	R
$\phi 178 \pm 2.0$	$\phi 50 \text{ min.}$	$\phi 13.0 \pm 0.2$	$\phi 21.0 \pm 0.8$	2.0 ± 0.5	1.0

	T	W
4mm wide tape	1.5max.	5 ± 1.0
8mm wide tape	2.5max.	10 ± 1.5
12mm wide tape	2.5max.	14 ± 1.5

Unit: mm

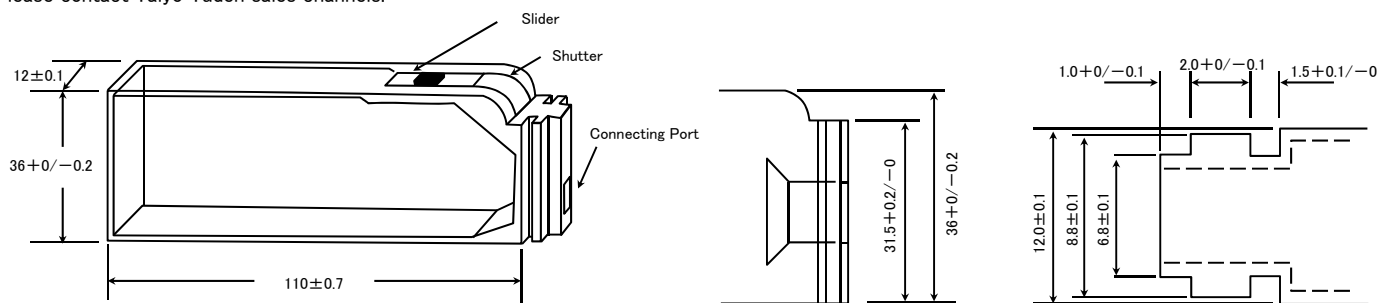
⑥Top Tape Strength

The top tape requires a peel-off force of 0.1 to 0.7N in the direction of the arrow as illustrated below.



⑦Bulk Cassette

The exchange of individual specification is necessary.
Please contact Taiyo Yuden sales channels.



Unit: mm

Multilayer Ceramic Capacitors

RELIABILITY DATA

1. Operating Temperature Range

Specified Value	Temperature Compensating(Class1)	Standard	-55 to +125°C		
		High Frequency Type			
	High Permittivity (Class2)			Specification	Temperature Range
			BJ	B	-25 to +85°C
				X5R	-55 to +85°C
			B7	X7R	-55 to +125°C
			C6	X6S	-55 to +105°C
			C7	X7S	-55 to +125°C
			LD(※)	X5R	-55 to +85°C
			F	F	-25 to +85°C
				Y5V	-30 to +85°C

Note: ※LD Low distortion high value multilayer ceramic capacitor

2. Storage Conditions

Specified Value	Temperature Compensating(Class1)	Standard	-55 to +125°C		
		High Frequency Type			
	High Permittivity (Class2)			Specification	Temperature Range
			BJ	B	-25 to +85°C
				X5R	-55 to +85°C
			B7	X7R	-55 to +125°C
			C6	X6S	-55 to +105°C
			C7	X7S	-55 to +125°C
			LD(※)	X5R	-55 to +85°C
			F	F	-25 to +85°C
				Y5V	-30 to +85°C

Note: ※LD Low distortion high value multilayer ceramic capacitor

3. Rated Voltage

Specified Value	Temperature Compensating(Class1)	Standard	50VDC, 25VDC, 16VDC
		High Frequency Type	50VDC, 25VDC, 16VDC
	High Permittivity (Class2)		50VDC, 35VDC, 25VDC, 16VDC, 10VDC, 6.3VDC, 4VDC, 2.5VDC

4. Withstanding Voltage (Between terminals)

Specified Value	Temperature Compensating(Class1)	Standard	No breakdown or damage		
		High Frequency Type			
	High Permittivity (Class2)				
Test Methods and Remarks		Class 1		Class 2	
	Applied voltage	Rated voltage × 3		Rated voltage × 2.5	
	Duration	1 to 5 sec.			
	Charge/discharge current	50mA max.			

5. Insulation Resistance

Specified Value	Temperature Compensating(Class1)	Standard	10000 MΩ min.		
		High Frequency Type			
	High Permittivity (Class2) Note 1		C ≤ 0.047 μF : 10000 MΩ min. C > 0.047 μF : 500MΩ · μF		
Test Methods and Remarks	Applied voltage		: Rated voltage		
	Duration		: 60 ± 5 sec.		
	Charge/discharge current		: 50mA max.		

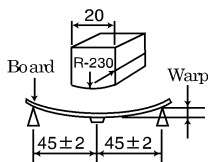
6. Capacitance (Tolerance)							
Specified Value	Temperature Compensating(Class1)	Standard	C□	0.2pF≦C≦5pF : ±0.25pF			
			U□	0.2pF≦C≦10pF : ±0.5pF			
			SL	C>10pF : ±5% or ±10%			
	High Frequency Type	CH	0.2pF≦C≦2pF : ±0.1pF				
		C>2pF : ±5%					
	High Permittivity (Class2)		BJ, B7, C6, C7, LD(※) : ±10% or ±20%, F : +80/−20% Note: ※LD Low distortion high value multilayer ceramic capacitor				
Test Methods and Remarks			Class 1		Class 2		
		Standard	High Frequency Type	C≦10μF		C>10μF	
	Preconditioning	None			Thermal treatment (at 150°C for 1hr) Note 2		
	Measuring frequency	1MHz±10%			1kHz±10%	120±10Hz	
	Measuring voltage Note	0.5 to 5Vrms			1±0.2Vrms	0.5±0.1Vrms	
	Bias application	None					
7. Q or Dissipation Factor							
Specified Value	Temperature Compensating(Class1)	Standard	C<30pF : Q≧400+20C C≧30pF : Q≧1000 (C:Nominal capacitance)				
		High Frequency Type	Refer to detailed specification				
	High Permittivity (Class2) Note 1		BJ, B7, C6, C7:2.5% max., F:7% max.				
Test Methods and Remarks			Class 1		Class 2		
		Standard	High Frequency Type	C≦10μF		C>10μF	
	Preconditioning	None			Thermal treatment (at 150°C for 1hr) Note 2		
	Measuring frequency	1MHz±10%	1GHz	1kHz±10%	120±10Hz		
	Measuring voltage Note 1	0.5 to 5Vrms			1±0.2Vrms	0.5±0.1Vrms	
	Bias application	None					
High Frequency Type Measuring equipment : HP4291A Measuring jig : HP16192A							
8. Temperature Characteristic (Without voltage application)							
Specified Value	Temperature Compensating(Class1)	Standard	Temperature Characteristic [ppm/°C]		Tolerance [ppm/°C]		
			C□ : 0	CG,CH, CJ, CK	G : ±30 H : ±60 J : ±120 K : ±250		
			U□ : −750	UJ, UK			
			SL : +350 to −1000				
	High Permittivity (Class2)	High Frequency Type	Temperature Characteristic [ppm/°C]		Tolerance [ppm/°C]		
			C□ : 0	CH	H : ±60		
				Specification	Capacitance change	Reference temperature	Temperature Range
			BJ	B	±10%	20°C	−25 to +85°C
				X5R	±15%	25°C	−55 to +85°C
			B7	X7R	±15%	25°C	−55 to +125°C
C6	X6S	±22%	25°C	−55 to +105°C			
C7	X7S	±22%	25°C	−55 to +125°C			
LD(※)	X5R	±15%	25°C	−55 to +85°C			
F	F	+30/−80%	20°C	−25 to +85°C			
	Y5V	+22/−82%	25°C	−30 to +85°C			
Note : ※LD Low distortion high value multilayer ceramic capacitor							
Test Methods and Remarks	Class 1 Capacitance at 20°C and 85°C shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation. $\frac{(C_{85}-C_{20})}{C_{20} \times \Delta T} \times 10^6 (\text{ppm}/^{\circ}\text{C}) \quad \Delta T=65$						
	Class 2 Capacitance at each step shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation.						
	Step	B、F		X5R、X7R、X6S、X7S、Y5V			
	1	Minimum operating temperature					
	2	20°C		25°C			
	3	Maximum operating temperature					

► This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification.
For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (<http://www.ty-top.com/>).

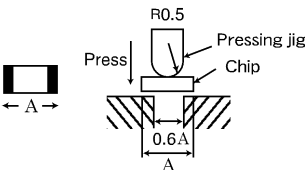
	$\frac{(C - C_2)}{C_2} \times 100 (\%)$ C : Capacitance in Step 1 or Step 3 C2 : Capacitance in Step 2
--	---

9. Deflection

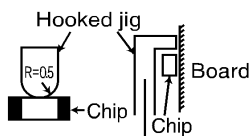
Specified Value	Temperature Compensating (Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 5\%$ or ± 0.5 pF, whichever is larger.
		High Frequency Type	Appearance : No abnormality Capacitance change : Within ± 0.5 pF
	High Permittivity (Class2)		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 30\%$ (F) Note: ※LD Low distortion high value multilayer ceramic capacitor

Test Methods and Remarks	<table><tr><td></td><td colspan="2">Multilayer Ceramic Capacitors</td></tr><tr><td></td><td>042, 063, ※105 Type</td><td>The other types</td></tr><tr><td>Board</td><td colspan="2">Glass epoxy-resin substrate</td></tr><tr><td>Thickness</td><td>0.8mm</td><td>1.6mm</td></tr><tr><td>Warp</td><td colspan="2">1mm</td></tr><tr><td>Duration</td><td colspan="2">10 sec.</td></tr></table>			Multilayer Ceramic Capacitors			042, 063, ※105 Type	The other types	Board	Glass epoxy-resin substrate		Thickness	0.8mm	1.6mm	Warp	1mm		Duration	10 sec.		 (Unit: mm) Capacitance measurement shall be conducted with the board bent
		Multilayer Ceramic Capacitors																			
		042, 063, ※105 Type	The other types																		
	Board	Glass epoxy-resin substrate																			
	Thickness	0.8mm	1.6mm																		
	Warp	1mm																			
	Duration	10 sec.																			
※105 Type thickness, C: 0.2mm ,P: 0.3mm.																					

10. Body Strength

Specified Value	Temperature Compensating (Class1)	Standard	—
		High Frequency Type	No mechanical damage.
	High Permittivity (Class2)		—
Test Methods and Remarks	High Frequency Type Applied force : 5N Duration : 10 sec. 		

11. Adhesive Strength of Terminal Electrodes

Specified Value	Temperature Compensating (Class1)	Standard	No terminal separation or its indication.
		High Frequency Type	
	High Permittivity (Class2)		
Test Methods and Remarks		Multilayer Ceramic Capacitors	
		042, 063 Type	105 Type or more
	Applied force	2N	5N
	Duration	30±5 sec.	
			

12. Solderability

Specified Value	Temperature Compensating (Class1)	Standard	At least 95% of terminal electrode is covered by new solder.
		High Frequency Type	
	High Permittivity (Class2)		
Test Methods and Remarks		Eutectic solder	Lead-free solder
	Solder type	H60A or H63A	Sn-3.0Ag-0.5Cu
	Solder temperature	230 ± 5°C	245 ± 3°C
	Duration	4 ± 1 sec.	

13. Resistance to Soldering

Specified Value	Temperature Compensating(Class1)	Standard	Appearance	: No abnormality
			Capacitance change	: Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$, whichever is larger.
			Q	: Initial value
			Insulation resistance	: Initial value
			Withstanding voltage	(between terminals) : No abnormality
	High Frequency Type		Appearance	: No abnormality
			Capacitance change	: Within $\pm 2.5\%$
			Q	: Initial value
			Insulation resistance	: Initial value
			Withstanding voltage	(between terminals) : No abnormality
High Permittivity (Class2) Note 1		Appearance	: No abnormality	
		Capacitance change	: Within $\pm 7.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 20\%$ (F)	
		Dissipation factor	: Initial value	
		Insulation resistance	: Initial value	
		Withstanding voltage	(between terminals): No abnormality	
		Note: ※LD Low distortion high value multilayer ceramic capacitor		

Test Methods and Remarks

	Class 1		
	042, 063 Type	105 Type	
Preconditioning	None		
Preheating	150°C, 1 to 2 min.	80 to 100°C, 2 to 5 min. 150 to 200°C, 2 to 5 min.	
Solder temp.	270±5°C		
Duration	3±0.5 sec.		
Recovery	6 to 24 hrs (Standard condition) Note 5		

	Class 2		
	042、063 Type	105, 107, 212 Type	316, 325 Type
Preconditioning	Thermal treatment (at 150°C for 1 hr) Note 2		
Preheating	150°C, 1 to 2 min.	80 to 100°C, 2 to 5 min. 150 to 200°C, 2 to 5 min.	80 to 100°C, 5 to 10 min. 150 to 200°C, 5 to 10 min.
Solder temp.	270±5°C		
Duration	3±0.5 sec.		
Recovery	24±2 hrs (Standard condition) Note 5		

14. Temperature Cycle (Thermal Shock)

Specified Value	Temperature Compensating (Class1)	Standard	Appearance	: No abnormality
			Capacitance change	: Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$, whichever is larger.
			Q	: Initial value
			Insulation resistance	: Initial value
			Withstanding voltage	(between terminals) : No abnormality
	High Frequency Type		Appearance	: No abnormality
			Capacitance change	: Within $\pm 0.25\text{pF}$
			Q	: Initial value
			Insulation resistance	: Initial value
			Withstanding voltage	(between terminals) : No abnormality
High Permittivity (Class2) Note 1		Appearance	: No abnormality	
		Capacitance change	: Within $\pm 7.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 20\%$ (F)	
		Dissipation factor	: Initial value	
		Insulation resistance	: Initial value	
		Withstanding voltage	(between terminals) : No abnormality	
		Note: ※LD Low distortion high value multilayer ceramic capacitor		

Test Methods and Remarks		Class 1	Class 2															
	Preconditioning	None	Thermal treatment (at 150°C for 1 hr) Note 2															
	1 cycle	<table><tr><td>Step</td><td>Temperature (°C)</td><td>Time (min.)</td></tr><tr><td>1</td><td>Minimum operating temperature</td><td>30±3</td></tr><tr><td>2</td><td>Normal temperature</td><td>2 to 3</td></tr><tr><td>3</td><td>Maximum operating temperature</td><td>30±3</td></tr><tr><td>4</td><td>Normal temperature</td><td>2 to 3</td></tr></table>		Step	Temperature (°C)	Time (min.)	1	Minimum operating temperature	30±3	2	Normal temperature	2 to 3	3	Maximum operating temperature	30±3	4	Normal temperature	2 to 3
		Step	Temperature (°C)	Time (min.)														
		1	Minimum operating temperature	30±3														
		2	Normal temperature	2 to 3														
3		Maximum operating temperature	30±3															
4	Normal temperature	2 to 3																
Number of cycles	5 times																	
Recovery	6 to 24 hrs (Standard condition) Note 5	24±2 hrs (Standard condition) Note 5																

► This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification.
For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (<http://www.tv-top.com/>).

15. Humidity (Steady State)

Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 5\%$ or $\pm 0.5\text{pF}$, whichever is larger. Q : $C < 10\text{pF}$: $Q \geq 200 + 10C$ $10 \leq C < 30\text{pF}$: $Q \geq 275 + 2.5C$ $C \geq 30\text{pF}$: $Q \geq 350$ (C:Nominal capacitance) Insulation resistance : $1000 \text{ M}\Omega$ min.	
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 0.5\text{pF}$, Insulation resistance : $1000 \text{ M}\Omega$ min.	
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 30\%$ (F) Dissipation factor : 5.0% max.(BJ, B7, C6, C7, LD(※)) 11.0% max.(F) Insulation resistance : $50 \text{ M}\Omega \mu\text{F}$ or $1000 \text{ M}\Omega$ whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor	
Test Methods and Remarks		Class 1		Class 2
		Standard	High Frequency Type	All items
	Preconditioning	None		Thermal treatment(at 150°C for 1 hr) Note 2
	Temperature	$40 \pm 2^{\circ}\text{C}$	$60 \pm 2^{\circ}\text{C}$	$40 \pm 2^{\circ}\text{C}$
	Humidity	90 to 95%RH		90 to 95%RH
	Duration	500+24/—0 hrs		500+24/—0 hrs
	Recovery	6 to 24 hrs (Standard condition) Note 5		24±2 hrs (Standard condition) Note 5

16. Humidity Loading

Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 7.5\%$ or $\pm 0.75\text{pF}$, whichever is larger. Q : $C < 30\text{pF} : Q \geq 100 + 10C/3$ $C \geq 30\text{pF} : Q \geq 200$ (C:Nominal capacitance) Insulation resistance : $500 \text{ M}\Omega$ min.	
		High Frequency Type	Appearance : No abnormality Capacitance change : $C \leq 2\text{pF} : \text{Within } \pm 0.4 \text{ pF}$ $C > 2\text{pF} : \text{Within } \pm 0.75 \text{ pF}$ (C:Nominal capacitance) Insulation resistance : $500 \text{ M}\Omega$ min.	
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 30\%$ (F) Dissipation factor : 5.0% max. (BJ, B7, C6, C7, LD(※)) 11.0% max. (F) Insulation resistance : $25 \text{ M}\Omega \mu \text{ F}$ or $500 \text{ M}\Omega$, whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor	
Test Methods and Remarks		Class 1		Class 2
		Standard	High Frequency Type	All items
	Preconditioning	None		Voltage treatment (Rated voltage are applied for 1 hour at 40°C) Note 3
	Temperature	$40 \pm 2^{\circ}\text{C}$	$60 \pm 2^{\circ}\text{C}$	$40 \pm 2^{\circ}\text{C}$
	Humidity	90 to 95%RH		90 to 95%RH
	Duration	$500 + 24 / - 0$ hrs		$500 + 24 / - 0$ hrs
	Applied voltage	Rated voltage		Rated voltage
	Charge/discharge current	50mA max.		50mA max.
	Recovery	6 to 24 hrs (Standard condition) Note 5		24 ± 2 hrs (Standard condition) Note 5

17. High Temperature Loading

Specified Value	Temperature Compensating (Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 3\%$ or $\pm 0.3\text{pF}$, whichever is larger. Q : $C < 10\text{pF}$: $Q \geq 200 + 10C$ $10 \leq C < 30\text{pF}$: $Q \geq 275 + 2.5C$ $C \geq 30\text{pF}$: $Q \geq 350$ (C: Nominal capacitance) Insulation resistance : $1000\text{ M}\Omega$ min.			
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 3\%$ or $\pm 0.3\text{pF}$, whichever is larger. Insulation resistance : $1000\text{ M}\Omega$ min.			
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 30\%$ (F) Dissipation factor : 5.0% max. (BJ, B7, C6, C7, LD(※)) 11.0% max. (F) Insulation resistance : $50\text{ M}\Omega\text{ }\mu\text{F}$ or $1000\text{ M}\Omega$, whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor			
Test Methods and Remarks		Class 1		Class 2		
		Standard	High Frequency Type	BJ, LD(※), F	C6	B7, C7
	Preconditioning	None		Voltage treatment (Twice the rated voltage shall be applied for 1 hour at 85°C , 105°C or 125°C) Note 3, 4		
	Temperature	Maximum operating temperature		Maximum operating temperature		
	Duration	$1000 + 48 / - 0$ hrs		$1000 + 48 / - 0$ hrs		
	Applied voltage	Rated voltage $\times 2$		Rated voltage $\times 2$ Note 4		
	Charge/discharge current	50mA max.		50mA max.		
	Recovery	6 to 24hr (Standard condition) Note 5		24 ± 2 hrs (Standard condition) Note 5		
	Note: ※LD Low distortion high value multilayer ceramic capacitor					

Note 1 The figures indicate typical specifications. Please refer to individual specifications in detail.

Note 2 Thermal treatment : Initial value shall be measured after test sample is heat-treated at $150 \pm 0 / - 10^\circ\text{C}$ for an hour and kept at room temperature for 24 ± 2 hours.

Note 3 Voltage treatment : Initial value shall be measured after test sample is voltage-treated for an hour at both the temperature and voltage specified in the test conditions, and kept at room temperature for 24 ± 2 hours.

Note 4 150% of rated voltage is applicable to some items. Please refer to their specifications for further information.

Note 5 Standard condition: Temperature: 5 to 35°C , Relative humidity: 45 to 85 % RH, Air pressure: 86 to 106kPa When there are questions concerning measurement results, in order to provide correlation data, the test shall be conducted under the following condition.

Temperature: $20 \pm 2^\circ\text{C}$, Relative humidity: 60 to 70 % RH, Air pressure: 86 to 106kPa Unless otherwise specified, all the tests are conducted under the "standard condition".

Precautions on the use of Multilayer Ceramic Capacitors

■ PRECAUTIONS

1. Circuit Design

Precautions

◆ Verification of operating environment, electrical rating and performance

1. A malfunction of equipment in fields such as medical, aerospace, nuclear control, etc. may cause serious harm to human life or have severe social ramifications.

Therefore, any capacitors to be used in such equipment may require higher safety and reliability, and shall be clearly differentiated from them used in general purpose applications.

◆ Operating Voltage (Verification of Rated voltage)

1. The operating voltage for capacitors must always be their rated voltage or less.

If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages shall be the rated voltage or less.

For a circuit where an AC or a pulse voltage may be used, the sum of their peak voltages shall also be the rated voltage or less.

2. Even if an applied voltage is the rated voltage or less reliability of capacitors may be deteriorated in case that either a high frequency AC voltage or a pulse voltage having rapid rise time is used in a circuit.

2. PCB Design

Precautions

◆ Pattern configurations (Design of Land-patterns)

1. When capacitors are mounted on PCBs, the amount of solder used (size of fillet) can directly affect the capacitor performance. Therefore, the following items must be carefully considered in the design of land patterns:

(1) Excessive solder applied can cause mechanical stresses which lead to chip breaking or cracking. Therefore, please consider appropriate land-patterns for proper amount of solder.

(2) When more than one component are jointly soldered onto the same land, each component's soldering point shall be separated by solder-resist.

◆ Pattern configurations (Capacitor layout on PCBs)

After capacitors are mounted on boards, they can be subjected to mechanical stresses in subsequent manufacturing processes (PCB cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering of the boards, etc.). For this reason, land pattern configurations and positions of capacitors shall be carefully considered to minimize stresses.

◆ Pattern configurations (Design of Land-patterns)

The following diagrams and tables show some examples of recommended land patterns to prevent excessive solder amounts.

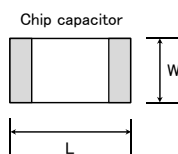
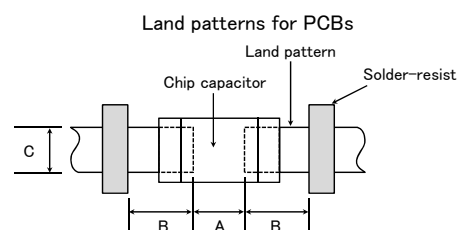
- (1) Recommended land dimensions for typical chip capacitors

● Multilayer Ceramic Capacitors : Recommended land dimensions

(unit: mm)

Wave-soldering

Type		107	212	316	325
Size	L	1.6	2.0	3.2	3.2
	W	0.8	1.25	1.6	2.5
A		0.8 to 1.0	1.0 to 1.4	1.8 to 2.5	1.8 to 2.5
B		0.5 to 0.8	0.8 to 1.5	0.8 to 1.7	0.8 to 1.7
C		0.6 to 0.8	0.9 to 1.2	1.2 to 1.6	1.8 to 2.5



Reflow-soldering

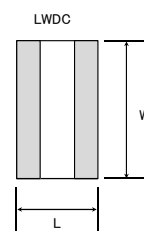
Type		042	063	105	107	212	316	325	432
Size	L	0.4	0.6	1.0	1.6	2.0	3.2	3.2	4.5
	W	0.2	0.3	0.5	0.8	1.25	1.6	2.5	3.2
A		0.15 to 0.25	0.20 to 0.30	0.45 to 0.55	0.8 to 1.0	0.8 to 1.2	1.8 to 2.5	1.8 to 2.5	2.5 to 3.5
B		0.15 to 0.20	0.20 to 0.30	0.40 to 0.50	0.6 to 0.8	0.8 to 1.2	1.0 to 1.5	1.0 to 1.5	1.5 to 1.8
C		0.15 to 0.30	0.25 to 0.40	0.45 to 0.55	0.6 to 0.8	0.9 to 1.6	1.2 to 2.0	1.8 to 3.2	2.3 to 3.5

Note: Recommended land size might be different according to the allowance of the size of the product.

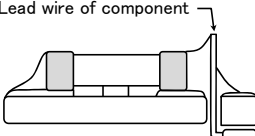
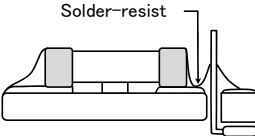
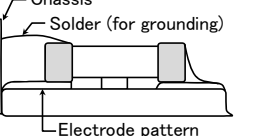
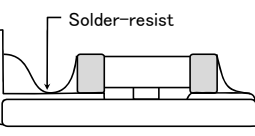
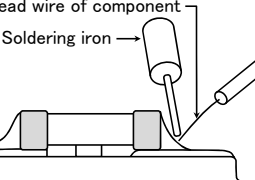
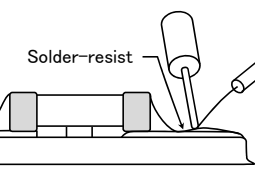
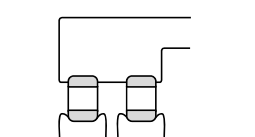
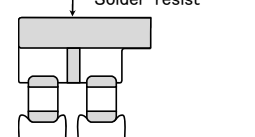
● LWDC: Recommended land dimensions for reflow-soldering

(unit: mm)

Type		105	107	212
Size	L	0.52	0.8	1.25
	W	1.0	1.6	2.0
A		0.18 to 0.22	0.25 to 0.3	0.5 to 0.7
B		0.2 to 0.25	0.3 to 0.4	0.4 to 0.5
C		0.9 to 1.1	1.5 to 1.7	1.9 to 2.1

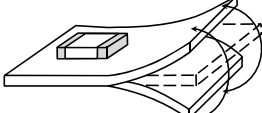
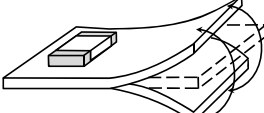


(2) Examples of good and bad solder application

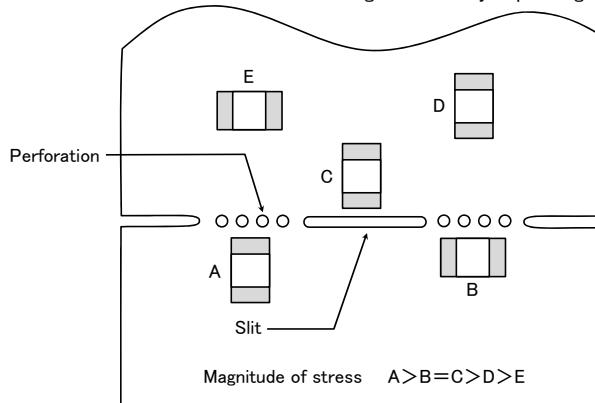
Item	Not recommended	Recommended
Mixed mounting of SMD and leaded components		
Component placement close to the chassis		
Hand-soldering of leaded components near mounted components		
Horizontal component placement		

◆ Pattern configurations (Capacitor layout on PCBs)

1-1. The following is examples of good and bad capacitor layouts ; capacitors shall be located to minimize any possible mechanical stresses from board warp or deflection.

Items	Not recommended	Recommended
Deflection of board		

1-2. The amount of mechanical stresses given will vary depending on capacitor layout. Please refer to diagram below.



1-3. When PCB is split, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful to most stressful: push-back, slit, V-grooving, and perforation. Thus, please consider the PCB, split methods as well as chip location.

3. Mounting

◆ Adjustment of mounting machine

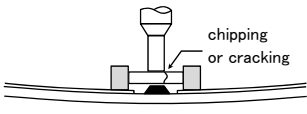
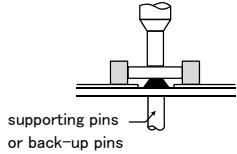
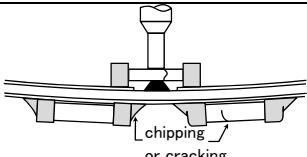
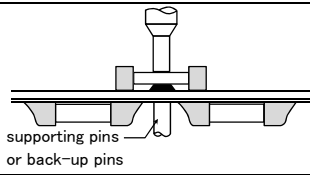
- When capacitors are mounted on PCB, excessive impact load shall not be imposed on them.
- Maintenance and inspection of mounting machines shall be conducted periodically.

◆ Selection of Adhesives

- When chips are attached on PCBs with adhesives prior to soldering, it may cause capacitor characteristics degradation unless the following factors are appropriately checked : size of land patterns, type of adhesive, amount applied, hardening temperature and hardening period. Therefore, please contact us for further information.

◆Adjustment of mounting machine

- When the bottom dead center of a pick-up nozzle is too low, excessive force is imposed on capacitors and causes damages. To avoid this, the following points shall be considerable.
 - The bottom dead center of the pick-up nozzle shall be adjusted to the surface level of PCB without the board deflection.
 - The pressure of nozzle shall be adjusted between 1 and 3 N static loads.
 - To reduce the amount of deflection of the board caused by impact of the pick-up nozzle, supporting pins or back-up pins shall be used on the other side of the PCB. The following diagrams show some typical examples of good and bad pick-up nozzle placement:

Item	Improper method	Proper method
Single-sided mounting		
Double-sided mounting		

- As the alignment pin is worn out, adjustment of the nozzle height can cause chipping or cracking of capacitors because of mechanical impact on the capacitors.
To avoid this, the monitoring of the width between the alignment pins in the stopped position, maintenance, check and replacement of the pin shall be conducted periodically.

◆Selection of Adhesives

Some adhesives may cause IR deterioration. The different shrinkage percentage of between the adhesive and the capacitors may result in stresses on the capacitors and lead to cracking. Moreover, too little or too much adhesive applied to the board may adversely affect components. Therefore, the following precautions shall be noted in the application of adhesives.

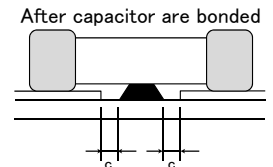
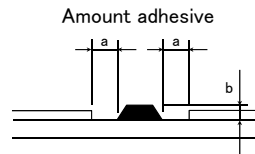
(1) Required adhesive characteristics

- The adhesive shall be strong enough to hold parts on the board during the mounting & solder process.
- The adhesive shall have sufficient strength at high temperatures.
- The adhesive shall have good coating and thickness consistency.
- The adhesive shall be used during its prescribed shelf life.
- The adhesive shall harden rapidly.
- The adhesive shall have corrosion resistance.
- The adhesive shall have excellent insulation characteristics.
- The adhesive shall have no emission of toxic gasses and no effect on the human body.

(2) The recommended amount of adhesives is as follows;

[Recommended condition]

Figure	212/316 case sizes as examples
a	0.3mm min
b	100 to 120 μ m
c	Adhesives shall not contact land



Technical considerations

4. Soldering

◆Selection of Flux

Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use;

- Flux used shall be less than or equal to 0.1 wt% (in Cl equivalent) of halogenated content. Flux having a strong acidity content shall not be applied.
- When shall capacitors are soldered on boards, the amount of flux applied shall be controlled at the optimum level.
- When water-soluble flux is used, special care shall be taken to properly clean the boards.

Precautions

◆Soldering

Temperature, time, amount of solder, etc. shall be set in accordance with their recommended conditions.

Sn-Zn solder paste can adversely affect MLOC reliability.

Please contact us prior to usage of Sn-Zn solder.

Technical considerations

◆Selection of Flux

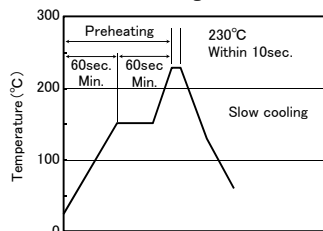
- When too much halogenated substance (Chlorine, etc.) content is used to activate flux, or highly acidic flux is used, it may lead to corrosion of terminal electrodes or degradation of insulation resistance on the surfaces of the capacitors.
- Flux is used to increase solderability in wave soldering. However if too much flux is applied, a large amount of flux gas may be emitted and may adversely affect the solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system.
- Since the residue of water-soluble flux is easily dissolved in moisture in the air, the residues on the surfaces of capacitors in high humidity conditions may cause a degradation of insulation resistance and reliability of the capacitors. Therefore, the cleaning methods and the capability of the machines used shall also be considered carefully when water-soluble flux is used.

◆Soldering

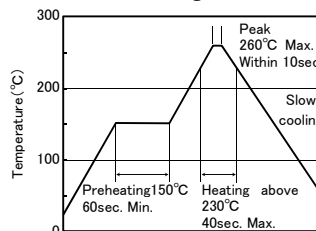
- Ceramic chip capacitors are susceptible to thermal shock when exposed to rapid or concentrated heating or rapid cooling.
- Therefore, the soldering must be conducted with great care so as to prevent malfunction of the components due to excessive thermal shock.
- Preheating : Capacitors shall be preheated sufficiently, and the temperature difference between the capacitors and solder shall be within 100 to 130°C.
- Cooling : The temperature difference between the capacitors and cleaning process shall not be greater than 100°C.

[Reflow soldering]

【Recommended conditions for eutectic soldering】

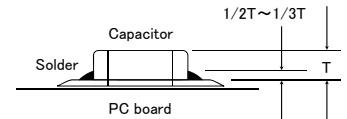


【Recommended condition for Pb-free soldering】



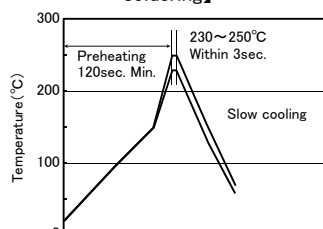
Caution

- ①The ideal condition is to have solder mass(fillet) controlled to 1/2 to 1/3 of the thickness of a capacitor.
- ②Because excessive dwell times can adversely affect solderability, soldering duration shall be kept as close to recommended times as possible.

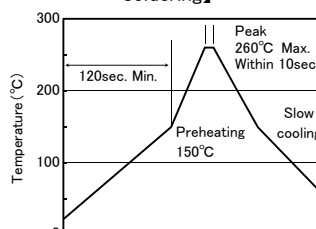


[Wave soldering]

【Recommended conditions for eutectic soldering】



【Recommended condition for Pb-free soldering】

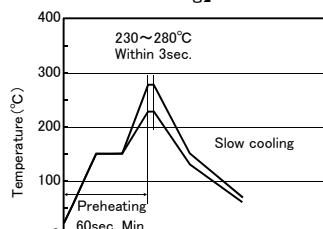


Caution

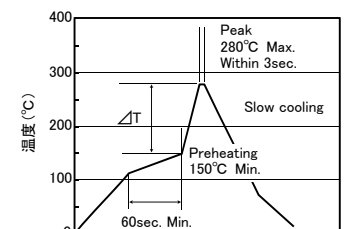
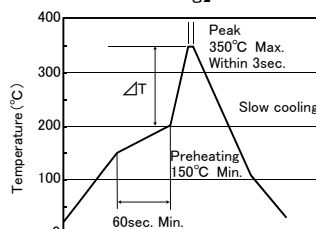
- ①Wave soldering must not be applied to capacitors designated as for reflow soldering only.

[Hand soldering]

【Recommended conditions for eutectic soldering】



【Recommended condition for Pb-free soldering】



Caution

- ①Use a 50W soldering iron with a maximum tip diameter of 1.0 mm.
- ②The soldering iron shall not directly touch capacitors.

	ΔT
316type or less	$\Delta T \leq 150^{\circ}\text{C}$

	ΔT
325type or more	$\Delta T \leq 130^{\circ}\text{C}$

5. Cleaning

◆Cleaning conditions

1. When PCBs are cleaned after capacitors mounting, please select the appropriate cleaning solution in accordance with the intended use of the cleaning. (e.g. to remove soldering flux or other materials from the production process.)
2. Cleaning condition shall be determined after it is verified by using actual cleaning machine that the cleaning process does not affect capacitor's characteristics.

Technical considerations

1. The use of inappropriate cleaning solutions can cause foreign substances such as flux residue to adhere to capacitors or deteriorate their outer coating, resulting in a degradation of the capacitor's electrical properties (especially insulation resistance).
2. Inappropriate cleaning conditions(insufficient or excessive cleaning) may adversely affect the performance of the capacitors. In the case of ultrasonic cleaning, too much power output can cause excessive vibration of PCBs which may lead to the cracking of capacitors or the soldered portion, or decrease the terminal electrodes' strength. Therefore, the following conditions shall be carefully checked:
 Ultrasonic output : 20 W/ℓ or less
 Ultrasonic frequency : 40 kHz or less
 Ultrasonic washing period : 5 min. or less

6. Resin coating and mold	
Precautions	1. With some type of resins, decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the capacitor's performance. 2. When a resin's hardening temperature is higher than capacitor's operating temperature, the stresses generated by the excessive heat may lead to damage or destruction of capacitors. The use of such resins, molding materials etc. is not recommended.
7. Handling	
Precautions	◆Splitting of PCB 1. When PCBs are split after components mounting, care shall be taken so as not to give any stresses of deflection or twisting to the board. 2. Board separation shall not be done manually, but by using the appropriate devices. ◆Mechanical considerations Be careful not to subject capacitors to excessive mechanical shocks. (1) If ceramic capacitors are dropped onto a floor or a hard surface, they shall not be used. (2) Please be careful that the mounted components do not come in contact with or bump against other boards or components.
8. Storage conditions	
Precautions	◆Storage 1. To maintain the solderability of terminal electrodes and to keep packaging materials in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible. •Recommended conditions Ambient temperature : Below 30°C Humidity : Below 70% RH The ambient temperature must be kept below 40°C. Even under ideal storage conditions, solderability of capacitor is deteriorated as time passes, so capacitors shall be used within 6 months from the time of delivery. •Ceramic chip capacitors shall be kept where no chlorine or sulfur exists in the air. 2. The capacitance values of high dielectric constant capacitors will gradually decrease with the passage of time, so care shall be taken to design circuits. Even if capacitance value decreases as time passes, it will get back to the initial value by a heat treatment at 150°C for 1 hour.
Technical considerations	If capacitors are stored in a high temperature and humidity environment, it might rapidly cause poor solderability due to terminal oxidation and quality loss of taping/packaging materials. For this reason, capacitors shall be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the capacitors.
※RCR-2335B (Safety Application Guide for fixed ceramic capacitors for use in electronic equipment) is published by JEITA. Please check the guide regarding precautions for deflection test, soldering by spot heat, and so on.	